

December 2011

FDMS86520

N-Channel PowerTrench® MOSFET 60 V, 42 A, 7.4 m Ω

Features

- Max $r_{DS(on)}$ = 7.4 m Ω at V_{GS} = 10 V, I_D = 14 A
- Max $r_{DS(on)} = 10.3 \text{ m}\Omega$ at $V_{GS} = 8 \text{ V}$, $I_D = 12.5 \text{ A}$
- Advanced Package and Silicon combination for low r_{DS(on)} and high efficiency
- Next generation enhanced body diode technology, engineered for soft recovery
- MSL1 robust package design
- 100% UIL tested
- RoHS Compliant

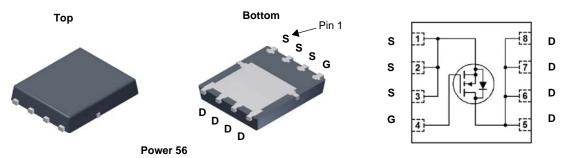


General Description

This N-Channel MOSFET has been designed specifically to improve the overall efficiency and to minimize switch node ringing of DC/DC converters using either synchronous or conventional switching PWM controllers.It has been optimized for low gate charge, low $r_{\rm DS(on)},$ fast switching speed and body diode reverse recovery performance.

Applications

- Primary DC-DC Switch
- Motor Bridge Switch
- Synchronous Rectifier



MOSFET Maximum Ratings T_A = 25 °C unless otherwise noted

Symbol	Parameter			Ratings	Units
V_{DS}	Drain to Source Voltage			60	V
V_{GS}	Gate to Source Voltage			±20	V
	Drain Current -Continuous (Package limited)	T _C = 25 °C		42	
	-Continuous (Silicon limited)	T _C = 25 °C		74	_
ID	-Continuous	T _A = 25 °C	(Note 1a)	14	A
	-Pulsed			80	
E _{AS}	Single Pulse Avalanche Energy		(Note 3)	86	mJ
D	Power Dissipation	T _C = 25 °C		69	W
P_{D}	Power Dissipation	T _A = 25 °C	(Note 1a)	2.5	VV
T_J, T_{STG}	Operating and Storage Junction Temperature Range			-55 to +150	°C

Thermal Characteristics

$R_{\theta JC}$	Thermal Resistance, Junction to Case	1.8	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (Note 1a)	50	C/VV

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDMS86520	FDMS86520	Power 56	13 "	12 mm	3000 units

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Units

Electrical Characteristics $T_J = 25$ °C unless otherwise noted

Parameter

Off Characteristics						
BV_{DSS}	Drain to Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	60			V
$\frac{\Delta BV_{DSS}}{\Delta T_{J}}$	Breakdown Voltage Temperature Coefficient	I_D = 250 μ A, referenced to 25 °C		30		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 48 V, V _{GS} = 0 V			1	μΑ
I _{GSS}	Gate to Source Leakage Current	$V_{GS} = \pm 20 \text{ V}, V_{DS} = 0 \text{ V}$			±100	nA

Test Conditions

Min

Тур

Max

On Characteristics

Symbol

V _{GS(th)}	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_{D} = 250 \mu A$	2.5	3.6	4.5	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	I_D = 250 μ A, referenced to 25 °C		-11		mV/°C
		V _{GS} = 10 V, I _D = 14 A		6.0	7.4	
r _{DS(on)}	r _{DS(on)} Static Drain to Source On Resistance	V _{GS} = 8 V, I _D = 12.5 A		7.3	10.3	mΩ
		V _{GS} = 10 V, I _D = 14 A, T _J = 125 °C		9	11	
9 _{FS}	Forward Transconductance	V _{DS} = 10 V, I _D = 14 A		49		S

Dynamic Characteristics

C _{iss}	Input Capacitance	V 20 V V 0 V	2140	2850	pF
C _{oss}	Output Capacitance	$V_{DS} = 30 \text{ V}, V_{GS} = 0 \text{ V},$ f = 1 MHz	624	830	pF
C _{rss}	Reverse Transfer Capacitance	1 - 1 101112	24	40	pF
R_g	Gate Resistance		0.7		Ω

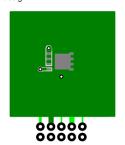
Switching Characteristics

t _{d(on)}	Turn-On Delay Time			17	31	ns
t _r	Rise Time	$V_{DD} = 30 \text{ V}, I_{D} = 14$	$V_{DD} = 30 \text{ V}, I_{D} = 14 \text{ A}, $ $V_{GS} = 10 \text{ V}, R_{GEN} = 6 \Omega$		14	ns
t _{d(off)}	Turn-Off Delay Time	V _{GS} = 10 V, R _{GEN}			32	ns
t _f	Fall Time			4	10	ns
Q _q	Total Gate Charge	V _{GS} = 0 V to 10 V		28	40	nC
Q_q	Total Gate Charge	$V_{GS} = 0 \text{ V to 8 V}$	V _{DD} = 30 V,	23	33	nC
Q_{gs}	Gate to Source Charge		I _D = 14 A	10.9		nC
Q_{ad}	Gate to Drain "Miller" Charge			5.6		nC

Drain-Source Diode Characteristics

V_{SD}	Source to Drain Diode Forward Voltage	$V_{GS} = 0 \text{ V}, I_{S} = 2.1 \text{ A}$	(Note 2)	0.74	1.2	\/
	Source to Drain blode Forward voltage	$V_{GS} = 0 \text{ V}, I_{S} = 14 \text{ A}$	(Note 2)	0.83	1.3	V
t _{rr}	Reverse Recovery Time	I _F = 14 A, di/dt = 100 A/μs		37	60	ns
Q _{rr}	Reverse Recovery Charge			21	35	nC
t _{rr}	Reverse Recovery Time	I _F = 14 A, di/dt = 300 A/μs		31	49	ns
Q _{rr}	Reverse Recovery Charge			40	64	nC

¹ R_{0JA} is determined with the device mounted on a 1 in² pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. R_{0JC} is guaranteed by design while R_{0CA} is determined by the user's board design.



a) 50 °C/W when mounted on a 1 in² pad of 2 oz copper



b) 125 °C/W when mounted on a minimum pad of 2 oz copper.

- 2. Pulse Test: Pulse Width < 300 μs , Duty cycle < 2.0%. 3. E_{AS} of 86 mJ is based on starting $T_J=25\,^{\circ}C$, L = 0.3 mH, $I_{AS}=24$ A, $V_{DD}=54$ V, $V_{GS}=10$ V.

Typical Characteristics $T_J = 25$ °C unless otherwise noted

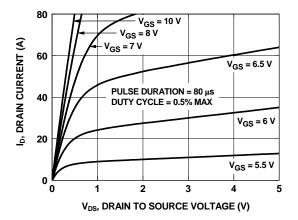


Figure 1. On-Region Characteristics

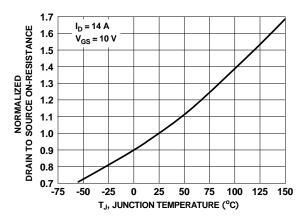


Figure 3. Normalized On-Resistance vs Junction Temperature

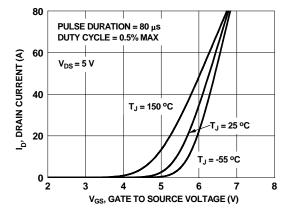


Figure 5. Transfer Characteristics

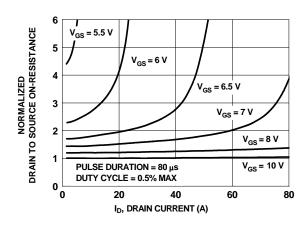


Figure 2. Normalized On-Resistance vs Drain Current and Gate Voltage

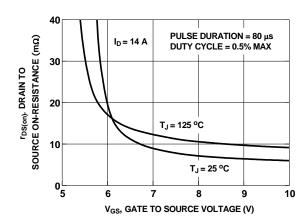


Figure 4. On-Resistance vs Gate to Source Voltage

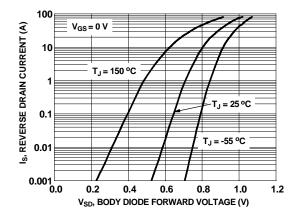


Figure 6. Source to Drain Diode Forward Voltage vs Source Current

Typical Characteristics $T_J = 25$ °C unless otherwise noted

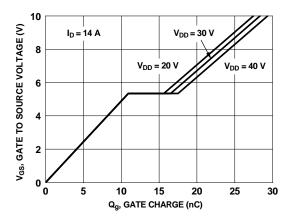


Figure 7. Gate Charge Characteristics

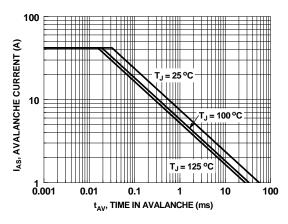


Figure 9. Unclamped Inductive Switching Capability

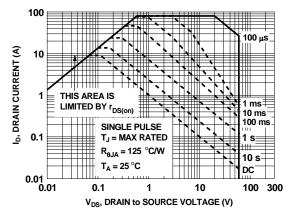


Figure 11. Forward Bias Safe Operating Area

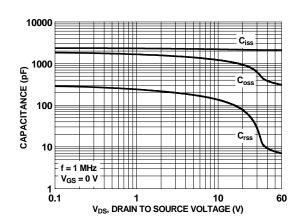


Figure 8. Capacitance vs Drain to Source Voltage

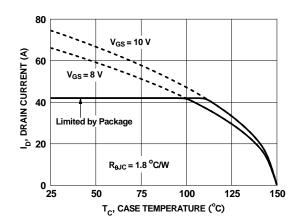


Figure 10. Maximum Continuous Drain Current vs Case Temperature

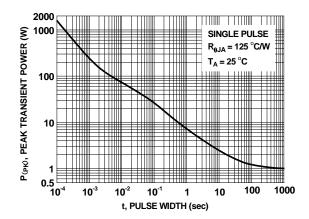


Figure 12. Single Pulse Maximum Power Dissipation

Typical Characteristics $T_J = 25$ °C unless otherwise noted

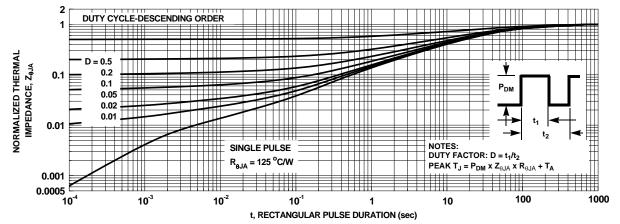


Figure 13. Junction-to-Ambient Transient Thermal Response Curve

Dimensional Outline and Pad Layout A 5.00 -1.27 PĶG В 6 8 5 4.52 PKG & 6.00 6.61 1.27 PIN #1 4 IDENT MÄY TOP VIEW APPEAR AS OPTIONAL -0.61 1.27 -SEE DETAIL A 3.81 LAND PATTERN RECOMMENDATION SIDE VIEW OPTIONAL DRAFT ANGLE MAY APPEAR 5.00 3.81 ON FOUR SIDES OF THE PACKAGE 1.27 0.46 0.36 (8X) (0.39)⊕ 0.10M C A B 3 0.71 __ 0.44 6.15 5.75 4.01±0.30 CHAMFER CORNER AS PIN #1 0.71 IDENT MÄY APPEAR AS OPTIONAL OPTIONAL TIE BARS MAY 6 APPEAR ON THESE AREAS (MAX. _ 3.86 _ 3.61 TIE BAR PROTRUSION: 0.15mm) BOTTOM VIEW NOTES: UNLESS OTHERWISE SPECIFIED PACKAGE STANDARD REFERENCE: A) JEDEC MO-240, ISSUE A, VAR. AA, DATED OCTOBER 2002. // 0.10 C ALL DIMENSIONS ARE IN MILLIMETERS. DIMENSIONS DO NOT INCLUDE BURRS OR MOLD FLASH, MOLD FLASH OR BURRS DOES NOT EXCEED 0.10MM. DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994. △ 0.08 C DRAWING FILE NAME: PQFN08AREV4 Ċ SEATING 1.10 0.90 PLANE DETAIL A SCALE: 2:1



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